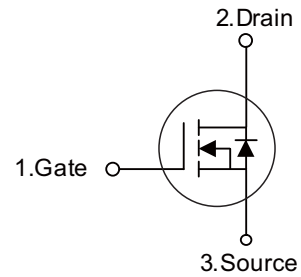


■ PRODUCT CHARACTERISTICS

$V_{DSS}$	30	V
$R_{DS(ON)-Max}$	2.5 at $V_{GS}=10V$	m $\Omega$
$R_{DS(ON)-Max}$	3.3 at $V_{GS}=4.5 V$	m $\Omega$
$I_D$	130	A

Symbol



■ APPLICATIONS

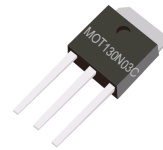
Power switch circuit of adaptor and charger.

■ FEATURES

- Fast switching
- Low ON resistance
- Low Gate Charge
- Low reverse transfer capacitances



TO-252



TO-251

■ ORDER INFORMATION

Order codes		Package	Packing
Halogen-Free	Halogen		
N/A	MOT130N03D	TO-252	2500 pieces /Reel
N/A	MOT130N03C	TO-251	70 pieces/Tube

■ ABSOLUTE MAXIMUM RATINGS ( $T_C = 25^\circ C$ , unless otherwise specified)

Symbol	Parameter	Rating	Units
$V_{DSS}$	Drain-to-Source Voltage	30	V
$I_D$	Continuous Drain Current $T_C = 25^\circ C$	130	A
	Continuous Drain Current $T_C = 100^\circ C$ (Package limited)	60	A
$I_{DM}^{a1}$	Pulsed Drain Current $T_C = 25^\circ C$ (Package limited)	240	A
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$E_{AS}^{a2}$	Single Pulse Avalanche Energy	1000	mJ
$P_D$	Power Dissipation $T_C = 25^\circ C$	83	W
	Derating Factor above $25^\circ C$	0.666	W/ $^\circ C$
$T_J, T_{stg}$	Operating Junction and Storage Temperature Range	150, -55 to 150	$^\circ C$

**■ ELECTRICAL CHARACTERISTICS** ( $T_J = 25^\circ\text{C}$ , unless otherwise noted)

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$V_{DSS}$	Drain to Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	30	--	--	V
$I_{DSS}$	Drain to Source Leakage Current	$V_{DS}=30V, V_{GS}=0V, T_J=25^\circ\text{C}$	--	--	1	$\mu A$
		$V_{DS}=24V, V_{GS}=0V, T_J=125^\circ\text{C}$	--	--	100	$\mu A$
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS}=+20V$	--	--	100	nA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS}=-20V$	--	--	-100	nA

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS}=10V, I_D=19A$	--	1.9	2.5	$m\Omega$
		$V_{GS}=4.5V, I_D=19A$		2.6	3.3	$m\Omega$
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	1.0	--	3.0	V

Pulse width  $t_p \leq 300\mu s, \delta \leq 2\%$

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_g$	Gate resistance	$V_{GS}=0V, V_{DS}=0V, f=1MHz$	--	5.3	--	$\Omega$
$C_{iss}$	Input Capacitance	$V_{GS}=0V, V_{DS}=15V, f=1.0MHz$	--	4893	--	pF
$C_{oss}$	Output Capacitance		--	818	--	
$C_{rss}$	Reverse Transfer Capacitance		--	482	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time	$V_{GS}=10V, R_G=6\Omega, V_{DD}=15V, I_D=50A$	--	14.8	--	ns
$t_r$	Rise Time		--	15.2	--	
$t_{d(OFF)}$	Turn-Off Delay Time		--	119.6	--	
$t_f$	Fall Time		--	59.2	--	
$Q_g$	Total Gate Charge	$V_{GS}=10V, V_{DD}=15V, I_D=50A$	--	79.1	--	nC
$Q_{gs}$	Gate to Source Charge		--	13.6	--	
$Q_{gd}$	Gate to Drain ("Miller") Charge		--	16.0	--	

**■ ELECTRICAL CHARACTERISTICS ( $T_J=25^\circ\text{C}$ , unless otherwise noted)**

Source-Drain Diode Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$I_S$	Continuous Source Current (Body Diode)		--	--	60	A
$I_{SM}$	Maximum Pulsed Current (Body Diode)		--	--	240	A
$V_{SD}$	Diode Forward Voltage	$I_S=50\text{A}, V_{GS}=0\text{V}$	--	--	1.2	V
$t_{rr}$	Reverse Recovery Time	$I_S=50\text{A}, T_J = 25^\circ\text{C}$ $dI_F/dt=100\text{A}/\mu\text{s}$ ,	--	44.4	--	ns
$Q_{rr}$	Reverse Recovery Charge		--	34.6	--	nC
$I_{RRM}$	Reverse Recovery Current		--	1.6	--	A
Pulse width $t_p \leq 300 \mu\text{s}$ , $\delta \leq 2\%$						

Symbol	Parameter	Max.	Units
$R_{\theta JC}$	Junction-to-Case	1.5	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Junction-to-Ambient	100	$^\circ\text{C}/\text{W}$

<sup>a1</sup>: Repetitive rating; pulse width limited by maximum junction temperature

<sup>a2</sup>:  $L=1\text{mH}$ ,  $I_D=44.73\text{A}$ , Start  $T_J=25^\circ\text{C}$ 
<sup>a3</sup>: Recommend soldering temperature defined by IPC/JEDEC J-STD 020

■ TEST CIRCUIT AND WAVEFORM

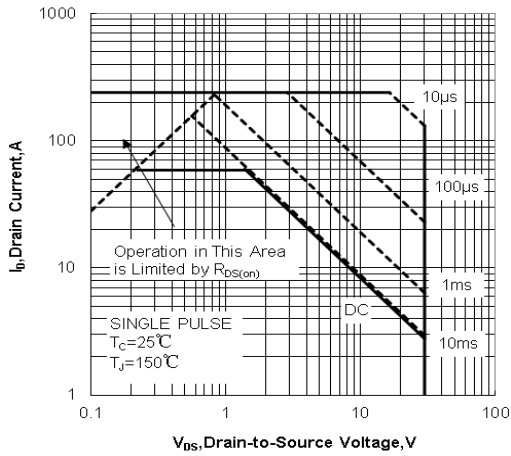


Figure1. Maximum Forward Bias Safe Operating Area

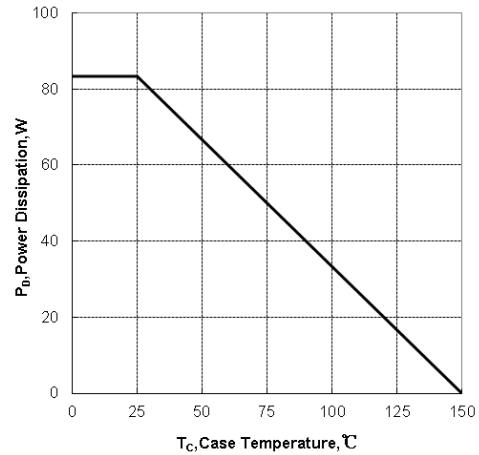


Figure2. Maximum Power Dissipation vs Case Temperature

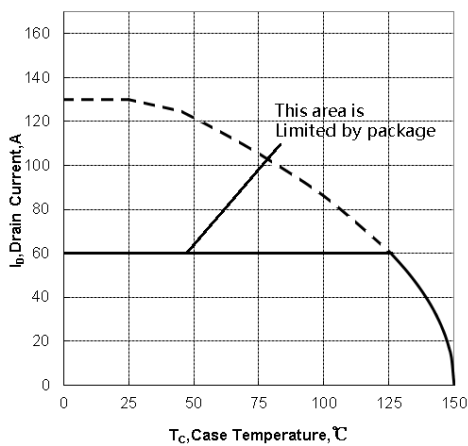


Figure3. Maximum Continuous Drain Current vs Case Temperature

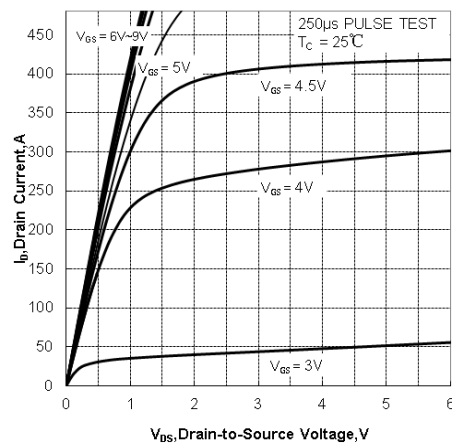


Figure 4. Typical Output Characteristics

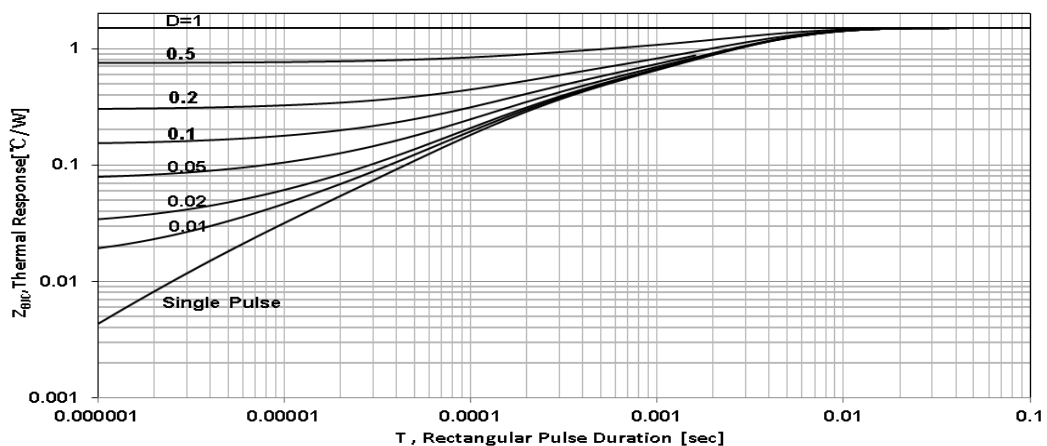


Figure5. Maximum Effective Transient Thermal Impedance, Junction-to-Case

■ TYPICAL CHARACTERISTICS

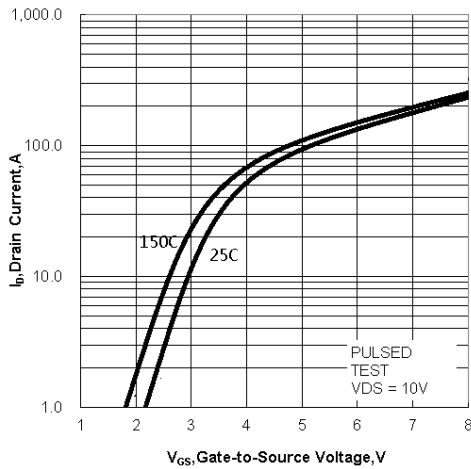


Figure 6. Typical Transfer Characteristics

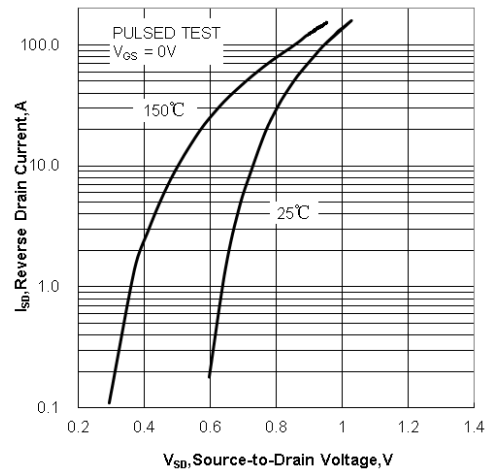


Figure 7. Typical Body Diode Transfer Characteristics

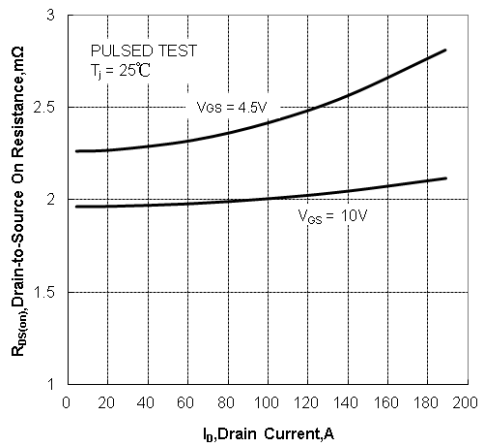


Figure 8. Drain-to-Source On Resistance vs Drain Current

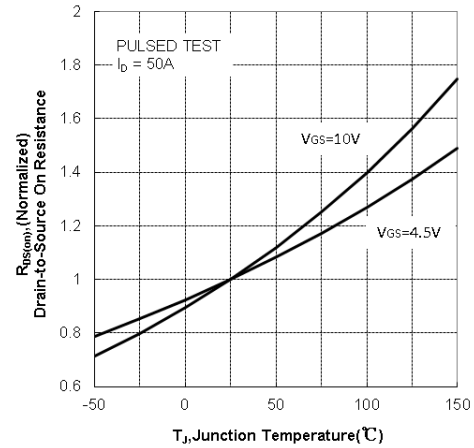


Figure 9. Normalized on Resistance vs Junction Temperature

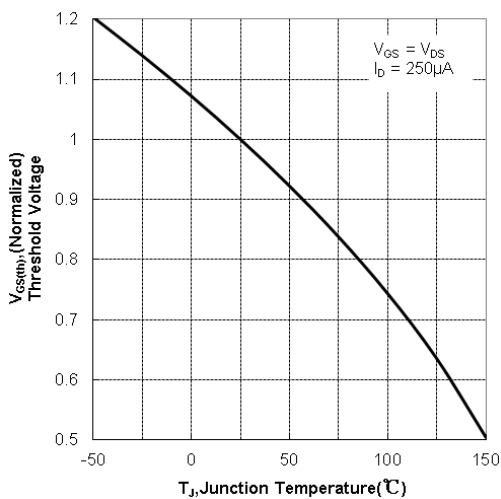


Figure 10. Normalized Theshold Voltage vs Junction Temperature

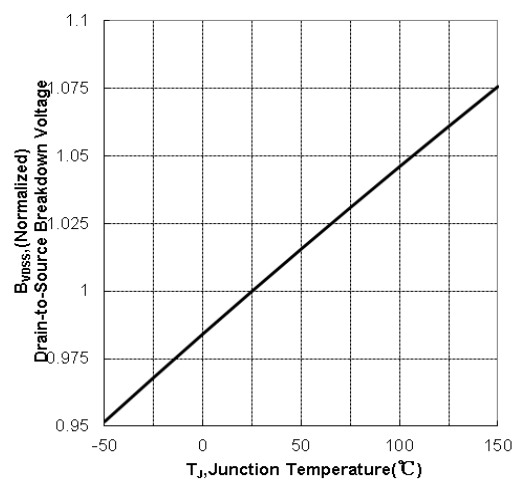
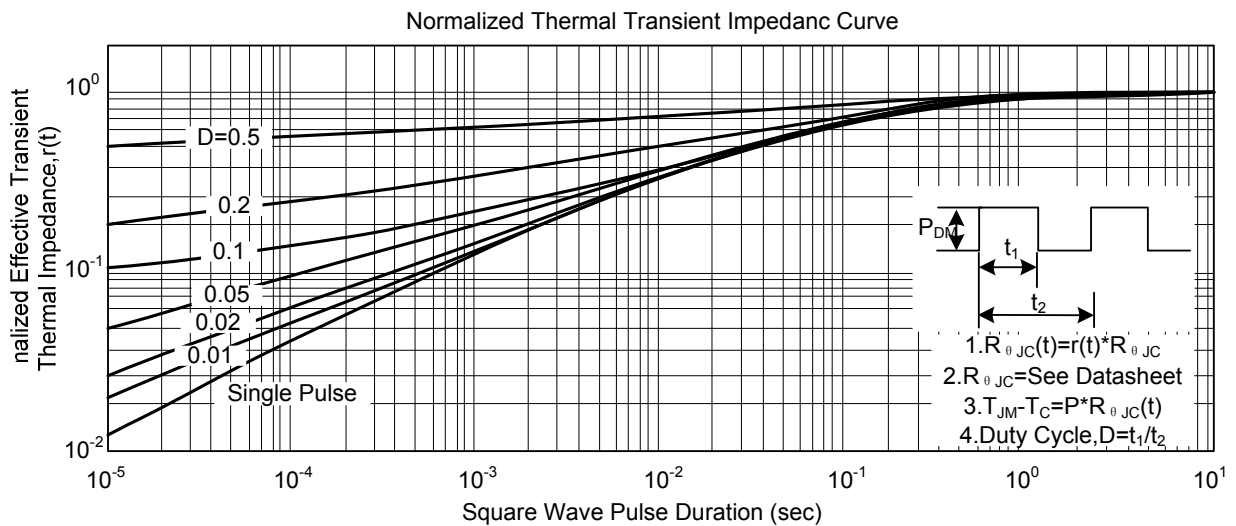
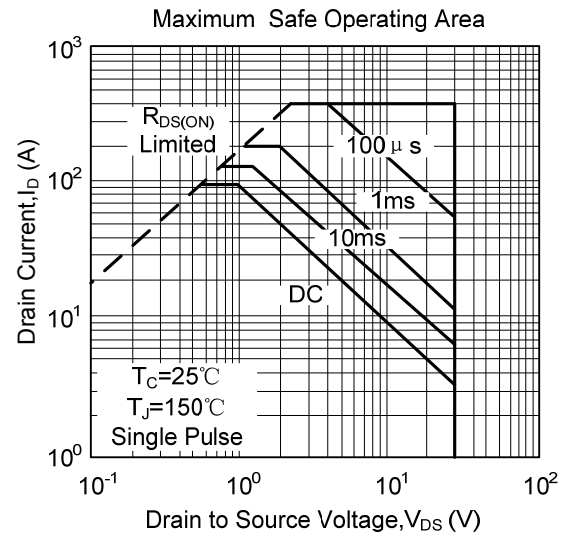
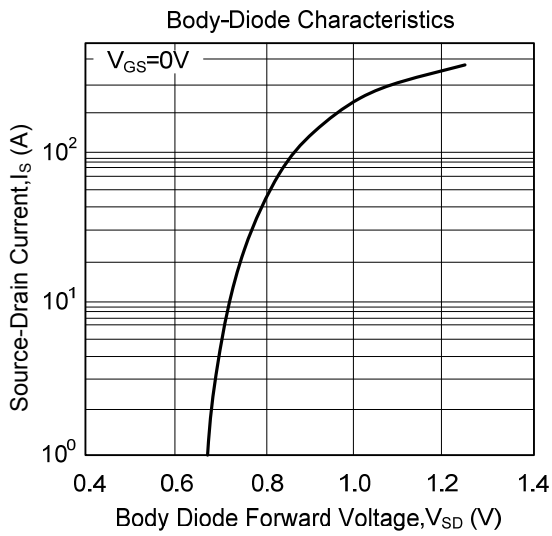
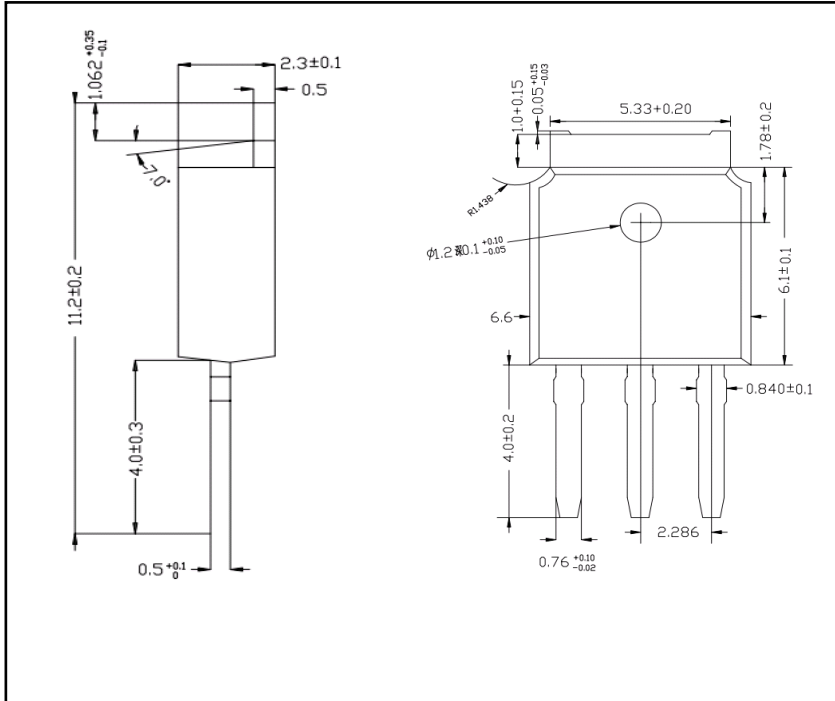


Figure 11. Normalized Breakdown Voltage vs Junction Temperature

■ TYPICAL CHARACTERISTICS(Cont.)



■ TO-251 PACKAGE OUTLINE DIMENSIONS



■ TO-252 PACKAGE OUTLINE DIMENSIONS

